

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10659744	NABEYAMA ET AL.
Examiner	Art Unit	
Tran, Dzung D	2613	

SEARCHED

Class	Subclass	Date	Examiner
398	81, 147	12/09/2007	TD
	Update search	06/22/2008	TD
	Update search	12/20/2008	TD
	Update search	04/25/2009	TD

SEARCH NOTES

Search Notes	Date	Examiner
398/class as listed (USPAT; US-PPGPUB; EPO; JPO and text search). See search history printout	12/09/2007	TD

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
398	188, 192	04/25/2009	TD